

M36P0R9070E0

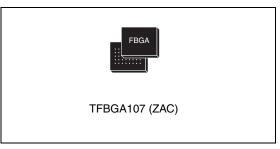
512 Mbit (x16, Multiple Bank, Multi-Level, Burst) Flash memory 128 Mbit (Burst) PSRAM, 1.8V supply, Multi-Chip Package

Feature summary

- Multi-Chip Package
 - 1 die of 512 Mbit (32Mb x 16, Multiple Bank, Multi-Level, Burst) Flash Memory
 - 1 die of 128Mbit (8Mb x16) PSRAM
- Supply voltage
 - $-V_{DDF} = V_{CCP} = V_{DDQ} = 1.7 \text{ to } 1.95 \text{V}$
 - V_{PPF} = 9V for fast program
- Electronic signature
 - Manufacturer Code: 20h
 - Device Code: 8819
- ECOPACK® package available

Flash memory

- Synchronous / Asynchronous Read
 - Synchronous Burst Read mode: 108MHz. 66MHz
 - Asynchronous Page Read mode
 - Random Access: 96ns
- Programming time
 - 4.2µs typical Word program time using Buffer Enhanced Factory Program command
- Memory organization
 - Multiple bank memory array: 64 Mbit banks
 - Four Extended Flash Array (EFA) Blocks of 64 Kbits
- Dual operations
 - program/erase in one Bank while read in others
 - No delay between read and write operations
- Security
 - 2112-bit user programmable OTP Cells
 - 64-bit unique device number
- 100,000 program/erase cycles per block
- Common Flash Interface (CFI)



- Block locking
 - All Blocks locked at power-up
 - Any combination of Blocks can be locked with zero latency
 - WP_F for Block Lock-Down
 - Absolute Write Protection with V_{PPF} = V_{SS}

PSRAM

- Access time: 70ns
- User-selectable operating modes
 - Asynchronous modes: Random Read, and Write, Page Read
 - Synchronous modes: NOR-Flash, Full Synchronous (Burst Read and Write)
- Asynchronous Page Read
 - Page Size: 4, 8 or 16 Words
 - Subsequent Read Within Page: 20ns
- Burst Read
 - Fixed Length (4, 8, 16 or 32 Words) or Continuous
 - Maximum Clock Frequency: 80MHz
- Low Power Consumption
 - Active Current: < 25mA
 - Standby Current: 200µA
 - Deep Power-Down Current: 10μA
- Low Power Features
 - Partial Array Self Refresh (PASR)
 - Deep Power-Down (DPD) Mode

November 2007 Rev 3 1/23

Contents M36P0R9070E0

Contents

| 1 | Sumr | mary description 6 |
|---|-------|---|
| 2 | Signa | al descriptions |
| | 2.1 | Address inputs (A0-A24) |
| | 2.2 | Data input/output (DQ0-DQ15) |
| | 2.3 | Latch Enable (\overline{L}) |
| | 2.4 | Clock (K) |
| | 2.5 | Wait (WAIT) 10 |
| | 2.6 | Flash Chip Enable input $(\overline{\overline{E}}_F)$ |
| | 2.7 | Flash Output Enable inputs (\overline{G}_F) |
| | 2.8 | Flash Write Enable (\overline{W}_F) |
| | 2.9 | Flash Write Protect (WP _F) |
| | 2.10 | Flash Reset (RP _F) |
| | 2.11 | PSRAM Chip Enable input (\overline{E}_P) |
| | 2.12 | PSRAM Write Enable (\overline{W}_P) |
| | 2.13 | PSRAM Output Enable (\overline{G}_P) |
| | 2.14 | PSRAM Upper Byte Enable (UB _P) |
| | 2.15 | PSRAM Lower Byte Enable ($\overline{\text{LB}}_{\text{P}}$) |
| | 2.16 | PSRAM Configuration Register Enable (CR _P) |
| | 2.17 | Deep Power-Down input (DPD _F) |
| | 2.18 | V _{DDF} Supply Voltages |
| | 2.19 | V _{CCP} Supply Voltage |
| | 2.20 | V _{DDQ} Supply Voltage |
| | 2.21 | V _{PPF} Program Supply Voltage |
| | 2.22 | V _{SS} Ground |
| 3 | Func | tional description14 |
| 4 | Maxir | num rating |
| 5 | DC a | nd AC parameters |

| M36P0 | Contents | |
|-------|--------------------|----|
| 6 | Package mechanical | 19 |
| 7 | Part numbering | 21 |
| 8 | Revision history | 22 |

Numonyx 3/23

List of tables M36P0R9070E0

List of tables

| | Signal names | |
|----------|---|----|
| Table 2. | Main operating modes | 15 |
| Table 3. | Absolute maximum ratings | 16 |
| Table 4. | Operating and AC measurement conditions | 17 |
| | Capacitance | |
| Table 7. | Ordering information scheme | 21 |
| Table 8. | Document revision history | 22 |
| | | |

√ numonyx

M36P0R9070E0 List of figures

List of figures

| | Logic diagram | |
|-----------|--|-----|
| Figure 2. | TFBGA connections (top view through package) | . 8 |
| Figure 3. | Functional block diagram | 14 |
| Figure 4. | AC measurement I/O waveform | 17 |
| Figure 5. | AC measurement load circuit | 18 |
| Figure 6. | TFBGA107 8 × 11mm - 9 × 12 active ball array, 0.8mm pitch, package outline | 19 |

Numonyx 5/23

1 Summary description

The M36P0R9070E0 combines two memory devices in one Multi-Chip Package:

- 512-Mbit Multiple Bank Flash memory (the M58PR512J).
- 128 Mbit PSRAM (the M69KB128AB).

The purpose of this document is to describe how the two memory components operate with respect to each other. It should be read in conjunction with the M58PRxxxJ and M69KB128AB datasheets, where all specifications required to operate the Flash memory and PSRAM components are fully detailed. The M58PR512J and M69KB128AB datasheets are available from www.numonyx.com.

Recommended operating conditions do not allow more than one memory to be active at the same time.

The memory is offered in a Stacked TFBGA107 package. It is supplied with all the bits erased (set to '1').

Figure 1. Logic diagram

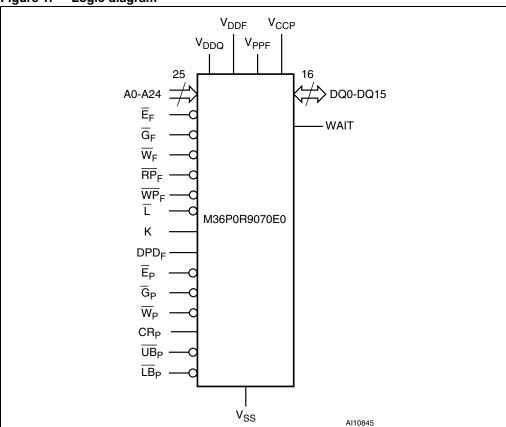


Table 1. Signal names

| Table 1. Olgilar i | iunes |
|------------------------|---|
| A0-A24 ⁽¹⁾ | Address Inputs |
| DQ0-DQ15 | Common Data Input/Output |
| V_{DDQ} | Common Flash and PSRAM Power Supply for I/O Buffers |
| V _{PPF} | Flash Memory Optional Supply Voltage for Fast Program & Erase |
| V _{DDF} | Flash Memory Power Supply |
| V _{CCP} | PSRAM Power Supply |
| V _{SS} | Ground |
| Ī | Latch Enable input |
| К | Burst Clock |
| WAIT | Wait Output |
| NC | Not Connected Internally |
| DU | Do Not Use as Internally Connected |
| Flash Memory | |
| Ē _F | Chip Enable input |
| \overline{G}_{F} | Output Enable Input |
| \overline{W}_{F} | Write Enable input |
| RP _F | Reset input |
| ₩P _F | Write Protect input |
| DPD _F | Deep Power-Down |
| PSRAM | |
| Ē _P | Chip Enable Input |
| G _P | Output Enable Input |
| \overline{W}_{P} | Write Enable Input |
| CR _P | Configuration Register Enable Input |
| ŪB _P | Upper Byte Enable Input |
| <u>LB</u> _P | Lower Byte Enable Input |
| | |

^{1.} A23-A24 are Address Inputs for the Flash memory component only.

Figure 2. TFBGA connections (top view through package) 1 2 3 4 5 6 7 8 9 Α V_{SS} DU В v_{DDF} NC V_{SS} С NC Κ LB_P V_{SS} A22 A23 $\overline{W_{\mathsf{P}}}$ A24 Α9 D ĒΡ A13 WPF Е A6 RP_F Α8 UB_P F A16 DQ8 DQ2 DQ10 DQ5 DQ13 NC WAIT G V_{DDQ} DQ0 DQ1 DQ3 DQ12 DQ14 DQ7 DU Н DQ9 DQ11 DQ4 DQ6 DQ15 V_{DDQ} EF NC , NC Κ NC NC NC V_{CCP}, V_{DDQ} CRP DU V_{SS} L V_{SS} V_{SS} V_{SS} $V_{\rm DDF}$ VSS ; V_{SS} V_{DDQ} DU DU DU DU DU DU М Al11098b

2 Signal descriptions

See *Figure 1., Logic diagram* and *Table 1., Signal names*, for a brief overview of the signals connected to this device.

2.1 Address inputs (A0-A24)

Addresses A0-A22 are common inputs for the Flash memory and PSRAM components. Addresses A23 and A24 are inputs for Flash memory components only. The Address Inputs select the cells in the memory array to access during Bus Read operations. During Bus Write operations they control the commands sent to the Command Interface of the internal state machine. The Flash memory is accessed through the Chip Enable signal (\overline{E}_F) and through the Write Enable signal (\overline{W}_F), while the PSRAM is accessed through the Chip Enable signal (\overline{E}_P) and the Write Enable signal (\overline{W}_P).

 $\overline{\mathsf{E}}_\mathsf{F}$ Low, and $\overline{\mathsf{E}}_\mathsf{P}$ must not be Low at the same time.

2.2 Data input/output (DQ0-DQ15)

The Data I/O output the data stored at the selected address during a Bus Read operation or input a command or the data to be programmed during a Bus Write operation.

For the PSRAM component, the upper Byte Data Inputs/Outputs (DQ8-DQ15) carry the data to or from the upper part of the selected address when Upper Byte Enable ($\overline{\text{UB}}_{\text{P}}$) is driven Low. The lower Byte Data Inputs/Outputs (DQ0-DQ7) carry the data to or from the lower part of the selected address when Lower Byte Enable ($\overline{\text{LB}}_{\text{P}}$) is driven Low. When both $\overline{\text{UB}}_{\text{P}}$ and $\overline{\text{LB}}_{\text{P}}$ are disabled, the Data Inputs/ Outputs are high impedance.

2.3 Latch Enable (\overline{L})

The Latch Enable pin is common to the Flash memory and PSRAM components.

For details of how the Latch Enable signal behaves, please refer to the datasheets of the respective memory components: M69KB128AB for the PSRAM and M58PR512J for the Flash memory.

2.4 Clock (K)

The Clock input pin is common to the Flash memory and PSRAM components.

For details of how the Clock signal behaves, please refer to the datasheets of the respective memory components: M69KB128AB for the PSRAM and M58PR512J for the Flash memory.

N numonyx 9/23

Signal descriptions M36P0R9070E0

2.5 Wait (WAIT)

WAIT is an output pin common to the Flash memory and PSRAM components. However the WAIT signal does not behave in the same way for the PSRAM and the Flash memory.

For details of how it behaves, please refer to the M69KB128AB datasheet for the PSRAM and to the M58PR512J datasheet for the Flash memory.

2.6 Flash Chip Enable input (\overline{E}_F)

The Flash Chip Enable input activates the control logic, input buffers, decoders and sense amplifiers of the Flash memory component selected. When Chip Enable is Low, V_{IL} , and Reset is High, V_{IH} , the device is in active mode. When Chip Enable is at V_{IH} the corresponding Flash memory are deselected, the outputs are high impedance and the power consumption is reduced to the standby level.

It is not allowed to have \overline{E}_F at V_{IL} and \overline{E}_P at V_{IL} at the same time. Only one memory component can be enabled at a time.

2.7 Flash Output Enable inputs (\overline{G}_F)

The Output Enable pins control the data outputs during Flash memory Bus Read operations.

2.8 Flash Write Enable (\overline{W}_F)

The Write Enable controls the Bus Write operation of the Flash memory Command Interface. The data and address inputs are latched on the rising edge of Chip Enable or Write Enable whichever occurs first.

2.9 Flash Write Protect (\overline{WP}_F)

Write Protect is an input that gives an additional hardware protection for each block. When Write Protect is Low, V_{IL} , Lock-Down is enabled and the protection status of the Locked-Down blocks cannot be changed. When Write Protect is at High, V_{IH} , Lock-Down is disabled and the Locked-Down blocks can be locked or unlocked. (See the Lock Status Table in the M58PR512J datasheet).

M36P0R9070E0 Signal descriptions

2.10 Flash Reset (\overline{RP}_F)

The Reset input provides a hardware reset of the Flash memories. When Reset is at V_{IL} , the memory is in Reset mode: the outputs are high impedance and the current consumption is reduced to the Reset Supply Current I_{DD2} . Refer to the M58PRxxxJ datasheet, for the value of I_{DD2} . After Reset all blocks are in the Locked state and the Configuration Register is reset. When Reset is at V_{IH} , the device is in normal operation. Exiting Reset mode the device enters Asynchronous Read mode, but a negative transition of Chip Enable or Latch Enable is required to ensure valid data outputs.

The Reset pin can be interfaced with 3V logic without any additional circuitry. It can be tied to V_{RPH} (refer to the M58PRxxxJ datasheet).

2.11 PSRAM Chip Enable input (\overline{E}_P)

The Chip Enable input activates the PSRAM when driven Low (asserted). When deasserted (V_{IH}) , the device is disabled, and goes automatically in low-power Standby mode or Deep Power-down mode.

2.12 PSRAM Write Enable (\overline{W}_P)

Write Enable, \overline{W}_P controls the Bus Write operation of the PSRAM. When asserted (V_{IL}), the device is in Write mode and Write operations can be performed either to the configuration registers or to the memory array.

2.13 PSRAM Output Enable (\overline{G}_P)

Output Enable, \overline{G}_{P} provides a high speed tri-state control, allowing fast read/write cycles to be achieved with the common I/O data bus.

2.14 PSRAM Upper Byte Enable (UB_P)

The Upper Byte En-able, $\overline{\text{UB}}_{\text{P}}$ gates the data on the Upper Byte Data Inputs/Outputs (DQ8-DQ15) to or from the upper part of the selected address during a Write or Read operation.

2.15 PSRAM Lower Byte Enable (\overline{LB}_P)

The Lower Byte Enable, \overline{LB}_{P} gates the data on the Lower Byte Data Inputs/Outputs (DQ0-DQ7) to or from the lower part of the selected address during a Write or Read operation.

If both \overline{LB}_P and \overline{UB}_P are disabled (High) during an operation, the device will disable the data bus from receiving or transmitting data. Although the device will seem to be deselected, it remains in an active mode as long as \overline{E}_P remains Low.

2.16 PSRAM Configuration Register Enable (CR_P)

When this signal is driven High, V_{IH} , Write operations load either the value of the Refresh Configuration Register (RCR) or the Bus configuration register (BCR).

Numonyx 11/23

Signal descriptions M36P0R9070E0

2.17 Deep Power-Down input (DPD_F)

The Deep Power-Down input is used to place the device in a Deep Power-Down mode. When the device is in Deep Power-Down mode, the memory cannot be modified and data is protected.

For further details on how the Deep Power-Down input signal works, please refer to the M58PR512J datasheet.

2.18 V_{DDF} Supply Voltages

V_{DDF} provides the power supply to the internal cores of the Flash memory. It is the main power supply for all Flash memory operations (Read, Program and Erase).

2.19 V_{CCP} Supply Voltage

 V_{CCP} provides the power supply to the internal core of the PSRAM device. It is the main power supply for all PSRAM operations.

2.20 V_{DDQ} Supply Voltage

 V_{DDQ} provides the power supply for the Flash memory and PSRAM I/O pins. This allows all Outputs to be powered independently of the Flash memory and SRAM core power supplies, V_{DDF} and V_{CCP}

2.21 V_{PPF} Program Supply Voltage

 V_{PPF} is both a control input and a power supply pin for the Flash memory. The two functions are selected by the voltage range applied to the pin.

If V_{PPF} is kept in a low voltage range (0V to V_{DDQ}) V_{PPF} is seen as a control input. In this case a voltage lower than V_{PPLK} gives an absolute protection against Program or Erase, while $V_{PPF} > V_{PP1}$ enables these functions (see the M58PRxxxJ datasheet for the relevant values). V_{PPF} is only sampled at the beginning of a Program or Erase; a change in its value after the operation has started does not have any effect and Program or Erase operations continue.

If V_{PPF} is in the range of V_{PPH} it acts as a power supply pin. In this condition V_{PPF} must be stable until the Program/Erase algorithm is completed.

2.22 V_{SS} Ground

V_{SS} is the common ground reference for all voltage measurements in the Flash (core and I/O Buffers) and PSRAM chips. It must be connected to the system ground.

Note:

Each Flash memory device in a system should have their supply voltage (V_{DDF}) and the program supply voltage V_{PPF} decoupled with a 0.1 μ F ceramic capacitor close to the pin (high frequency, inherently low inductance capacitors should be as close as possible to the package). See Figure 5., AC measurement load circuit. The PCB track widths should be sufficient to carry the required V_{PPF} program and erase currents.

N numonyx 13/23

3 Functional description

The PSRAM and Flash memory components have separate power supplies but share the same grounds. They are distinguished by two Chip Enable inputs: \overline{E}_F for Flash and \overline{E}_P for the PSRAM.

Recommended operating conditions do not allow more than one device to be active at a time. The most common example is a simultaneous read operations on the Flash memory and the PSRAM which would result in a data bus contention. Therefore it is recommended to put the other devices in the high impedance state when reading the selected device.

Figure 3. Functional block diagram

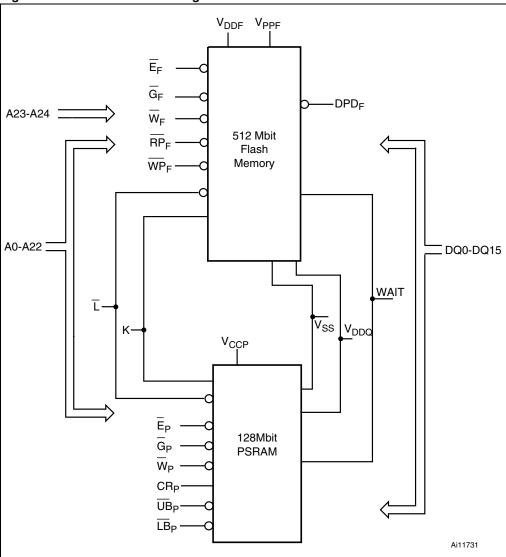


Table 2. Main operating modes⁽¹⁾

| Operation | Ē _F | \overline{G}_{F} | W _F | RP _F | DPD _F | WAIT (3) | Ē | Ē _P | ₩ _P | <mark>G</mark> ₽ | UB _P | LB _P | CR₽ | A19 | A18 | A0- A17 A20- A22 | DQ0- DQ7 | DQ8- DQ15 | | | |
|---|--|---|--|--|--|--|--|---|---|--|----------------------------|-----------------|-----------------|--|---|--|--|--|-----------------|----------------|----------------|
| Bus Read | V_{IL} | V _{IL} V _{IL} V _{IH} V _{IH} de-a ⁽⁴ | | | | | $V_{IL}^{(5)}$ | | | | | | | | | | Data Output | | | | |
| Bus Write | V_{IL} | | | | | | V _{IL} ⁽⁵⁾ | PSRAM must be disabled | | | | | | Data Input | | | | | | | |
| Address Latch | V _{IL} | Х | V _{IH} | V _{IH} | | | V _{IL} | | 1 Of 17 tivi fridot be disabled | | | | | Data Oi Hi-2 | utput or Z ⁽⁶⁾ | | | | | | |
| Output Disable | V_{IL} | V_{IH} | V_{IH} | V_{IH} | de-a ⁽⁴⁾ | Hi-Z | Х | | | | | | | | | | Hi | -Z | | | |
| Standby | V_{IH} | Х | Х | | de-a ⁽⁴⁾ | Hi-Z | Х | | | | | | | | | | Hi | -Z | | | |
| Reset | Χ | Х | Х | V_{IL} | de-a ⁽⁴⁾ | Hi-Z | Χ | | , | ٩ny | PSR | AM n | node | is allo | wed | | Hi | -Z | | | |
| Deep Power- Down | V _{IH} | - | | | | Hi | -Z | | | | | | | | | | | | | | |
| Word Read | | | | | | | | | | V _{IL} | V _{IL} | V _{IL} | V _{IL} | | Valid | | Output Valid | Output Valid | | | |
| Lower Byte Read | | | | | | | | | V _{IH} | V _{IL} | V _{IH} | V _{IL} | V _{IL} | | Valid | | Output Valid | High-Z | | | |
| Upper Byte Read | | | | | | | | | V _{IL} | V _{IL} | V _{IH} | V _{IL} | | Valid | | High-Z | Output Valid | | | | |
| Word Write | | | | | | | | | | | | | Х | V _{IL} | V _{IL} | V _{IL} | | Valid | | Input Valid | Input Valid |
| Lower Byte Write | The | | | | | Low- | V _{IL} | V _{IL} V | ^{'IL} V _{IL} | V _{IL} | Х | V _{IH} | V _{IL} | V _{IL} | | Valid | | Input Valid | Invalid | | |
| Upper Byte Write | | | | | | | | | | | Х | V _{IL} | V _{IH} | V _{IL} | | Valid | | Invalid | Input Valid | | |
| Read CR (CR Controlled Method) | | | | | | | | | | V _{IH} | V _{IL} | V _{IL} | V _{IL} | V | 0(BC | R)X1 | | | RCR/ Content | | |
| Program CR (CR Controlled) ⁽⁹⁾ | | | | | | | V _{IH} | х | Х | х | VIH | 10(E | BCR) | BCR/ RCR Data | Hig | h-Z | | | | | |
| No Operation | | Any Flash memory mode is allowed | | | | | | Х | Х | Х | Х | V_{IL} | Х | Χ | Х | > | (| | | | |
| Deep Power- Down ⁽¹⁰⁾ | Any | | | Hi-Z | х | V _{IH} | х | х | Х | Х | Х | Х | Х | Х | Hig | h-Z | | | | | |
| Standby | | io anomou | | | | | | V _{IH} | Х | Х | Χ | Χ | V_{IL} | Х | Х | Х | Hig | h-Z | | | |
| _E_ | Bus Read Bus Write Address Latch Dutput Disable Standby Reset Deep Power- Down Word Read Lower Byte Read Upper Byte Read Word Write Lower Byte Write Upper Byte Write Upper Byte Write Combrolled Method) Program CR CR Controlled) Operation Deep Power- Down(10) | Bus Read V _{IL} Bus Write V _{IL} Address Latch V _{IL} Dutput Disable V _{IL} Standby V _{IH} Reset X Deep Power- Down VIH Word Read Lower Byte Read Upper Byte Read Vord Write Lower Byte Write Upper Byte Vrite Read CR (CR Controlled Method) Program CR CR Controlled) No Operation Deep Power- Down Any Down(10) | Bus Read Sus Write Address Latch Output Disable Standby Reset Output Disable VIL Output Disable VIL VIH X Output Disable VIL VIH X Output Disable VIL VIH X A Output Disable VIL VIH X X VIH X A Output Disable VIL VIH X X X VIH X A Output Disable VIL VIH X X A Output Disable VIL VIH X X A Output Disable VIL VIH X A A Output Disable VIL VIH X A A A Output Disable VIL VIH X A A A A Output Disable VIL VIH X A A A A A A A A A A A A | Bus Read Output Disable Output Output Output Output Output Disable Output Outpu | Bus Read VIL VIL VIH VIH Bus Write VIL VIH VIH Address Latch VIL VIH VIH Output Disable VIL VIH VIH Output Disable VIH X X X X VIH Output Disable Output Disable VIH X X X VIH Output Disable VIH VIH VIH VIH VIH VIH VIH VIH | Bus Read VIL VIL VIH VIH de-a ⁽⁴⁾ Bus Write VIL VIH VIH VIH de-a ⁽⁴⁾ Address Latch VIL VIH VIH VIH de-a ⁽⁴⁾ Dutput Disable VIL VIH VIH VIH de-a ⁽⁴⁾ Baset VIH X X VIH de-a ⁽⁴⁾ Baset VIH X X X VIH de-a ⁽⁴⁾ Deep Power-Down VIH X X X VIH a ⁽⁷⁾ Word Read Down Byte Read Down Byte Read Word Write Dipper Byte Write Dipper Byte Write Read CR (CR Controlled Method) Program CR CR Controlled) Do Operation Deep Power-Down Any Flash memory mode is allowed | Bus Read VIL VIL VIH VIH de-a ⁽⁴⁾ Bus Write VIL VIH VIH VIH de-a ⁽⁴⁾ Address Latch VIL VIH VIH VIH de-a ⁽⁴⁾ Dutput Disable VIL VIH VIH VIH de-a ⁽⁴⁾ Beset VIH X X VIH de-a ⁽⁴⁾ Hi-Z Beset VIH X X VIH de-a ⁽⁴⁾ Hi-Z Deep Power-Down VIH X X VIH de-a ⁽⁴⁾ Hi-Z Word Read Deep Power-Down VIH X X X VIH a ⁽⁷⁾ Hi-Z Word Write Deep Byte Read Word Write Deep Byte Write Bread CR (CR Controlled Method) Program CR CR Controlled) No Operation Deep Power-Down Deep Power- | Bus Read VIL VIL VIH VIH de-a ⁽⁴⁾ Address Latch VIL VIH VIH VIH de-a ⁽⁴⁾ Dutput Disable VIL VIH VIH VIH de-a ⁽⁴⁾ Dutput Disable VIL VIH VIH VIH de-a ⁽⁴⁾ Dutput Disable VIH X X VIH de-a ⁽⁴⁾ Reset X X X VIH de-a ⁽⁴⁾ Deep Power-Down VIH X X VIH aa ⁽⁷⁾ Hi-Z X Word Read Lower Byte Read Upper Byte Read Word Write Depen Byte Write Read CR (CR Controlled Method) Program CR CR Controlled Method Program CR CR Controlled Method Program CR CR CR Controlled Method Program CR CR CR Controlled Method Program CR CR CR Chick VIII VIII VIII VIII VIII de-a(4) Program CR C | Bus Read VIL VIL VIH VIH de-a ⁽⁴⁾ Sus Write VIL VIH VIH VIH de-a ⁽⁴⁾ Address Latch VIL VIH VIH VIH de-a ⁽⁴⁾ Output Disable VIL VIH VIH VIH de-a ⁽⁴⁾ Standby VIH X X VIH de-a ⁽⁴⁾ Reset X X X VIH de-a ⁽⁴⁾ Output Disable VIH X X VIH de-a ⁽⁴⁾ Output Disable VIH X X VIH de-a ⁽⁴⁾ Reset X X X VIH de-a ⁽⁴⁾ Output Disable VIH X X VIH de-a ⁽⁴⁾ Output Disable VIH X X VIH de-a ⁽⁴⁾ Output Disable VIH X X VIH de-a ⁽⁴⁾ Output Disable In I | Bus Read V _{IL} V _{IL} V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} ⁽⁵⁾ Bus Write V _{IL} V _{IH} V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} ⁽⁵⁾ Address Latch V _{IL} X V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} Dutput Disable V _{IL} V _{IH} V _{IH} V _{IH} de-a ⁽⁴⁾ Hi-Z X Standby V _{IH} X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Beset X X X X V _{IL} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X V _{IH} a ⁽⁷⁾ Hi-Z X Word Read Disper Byte Read Word Write Disper Byte Write Bead CR (CR Controlled Method) Program CR CR CR CR CR Controlled Method) Program CR | Bus Read | Bus Read | Bus Read | Bus Read V _{IL} V _{IL} V _{IL} V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} V _{IL} | Bus Read V _{IL} V _{IL} V _{IH} V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} ⁽⁵⁾ Bus Write V _{IL} V _{IH} V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} ⁽⁵⁾ Address Latch V _{IL} X V _{IH} V _{IH} de-a ⁽⁴⁾ V _{IL} Dutput Disable V _{IL} V _{IH} V _{IH} V _{IH} de-a ⁽⁴⁾ Hi-Z X Standby V _{IH} X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} de-a ⁽⁴⁾ Hi-Z X Deep Power-Down V _{IH} X X X V _{IH} V _{IH} V _{IL} | Sus Read V V V V V V V | Operation E G W RP DPD WAIT C E W G UB LB CR A19 A18 A17 A20 A22 | Operation E_F G_F W_F RF_F DPD_F WAIT C E_F W_F G_F UB_F UB_F CR_F A19 A18 A17 A20 A20 A20 DQD A20 DQD | | | |

- 1. X = Don't care, de-a = de-asserted, a = asserted, CR = Configuration Register.
- 2. The $\ensuremath{\mathsf{DPD_F}}$ signal polarity depends on the value of the ECR14 bit.
- 3. In the Flash memory the WAIT signal polarity is configured using the Set Configuration Register command.
- 4. If ECR15 is set to '0', the Flash memory cannot enter the Deep Power-Down mode, even if DPDF is asserted.
- 5. In the Flash memory \overline{L} can be tied to V_{IH} if the valid address has been previously latched.
- 6. Depends on \overline{G}_F .
- 7. ECR15 has to be set to '1' for the Flash memory to enter Deep Power-Down.
- 8. A18 and A19 are used to select the BCR, RCR or DIDR registers.
- 9. BCR and RCR only.
- 10. Bit 4 of the Refresh Configuration Register must be set to '0', bit 4 (BCR4) of the Bus Configuration Register must be set to '0', and E has to be maintained High, V_{IH}, during Deep Power-Down mode.

Numonyx 15/23

Maximum rating M36P0R9070E0

4 Maximum rating

Stressing the device above the rating listed in the Absolute Maximum Ratings table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the Numonyx SURE Program and other relevant quality documents.

Table 3. Absolute maximum ratings

| Symbol | Parameter | Va | Unit | |
|--------------------|--|-------------|------|-------|
| Symbol | Falanielei | Min | Max | Oilit |
| T _A | Ambient Operating Temperature | -30 | 85 | °C |
| T _{BIAS} | Temperature Under Bias | -30 | 85 | °C |
| T _{STG} | Storage Temperature | - 55 | 125 | °C |
| V _{IO} | Input or Output Voltage | -0.2 | 2.45 | V |
| V _{DD} | Supply Voltage | -0.2 | 2.45 | V |
| V_{DDQ} | Input/Output Supply Voltage | -0.2 | 2.45 | V |
| V _{PP} | Program Voltage | -1.0 | 11.5 | V |
| Io | Output Short Circuit Current | | 100 | mA |
| t _{VPPH} | Time for V _{PP} at V _{PPH} | | 100 | hours |

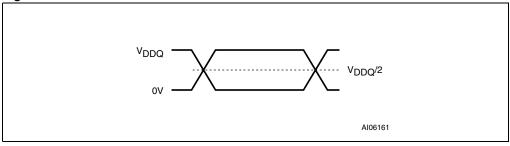
5 DC and AC parameters

This section summarizes the operating measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC characteristics Tables that follow, are derived from tests performed under the Measurement Conditions summarized in *Table 4., Operating and AC measurement conditions*. Designers should check that the operating conditions in their circuit match the operating conditions when relying on the quoted parameters.

Table 4. Operating and AC measurement conditions

| Parameter | Flash | memory | PSF | Unit | |
|---|-----------------------|-----------------------|-----------------------|------------------|----|
| Farameter | Min | Max | Min | Max | |
| V _{CCP} Supply Voltage | _ | _ | 1.7 | 1.95 | V |
| V _{DDF} Supply Voltage | 1.7 | 1.95 | _ | _ | V |
| V _{DDQ} Supply Voltage | 1.7 | 1.95 | 1.7 | 1.95 | V |
| V _{PPF} Supply Voltage (Factory environment) | 8.5 | 9.5 | _ | _ | V |
| V _{PPF} Supply Voltage (Application environment) | -0.4 | V _{DDQ} +0.4 | _ | _ | V |
| Ambient Operating Temperature | -30 | 85 | -30 | 85 | °C |
| Load Capacitance (C _L) | | 30 | 3 | pF | |
| Impedance Output (Z ₀) | 50 | | | | Ω |
| Output Circuit Protection Resistance (R) | 50 | | | Ω | |
| Input Rise and Fall Times | | 3 | | 2 | ns |
| Input Pulse Voltages | 0 to V _{DDQ} | | 0 to V _{DDQ} | | V |
| Input and Output Timing Ref. Voltages | V _C | _{DQ} /2 | V_{DD} | _{OQ} /2 | V |

Figure 4. AC measurement I/O waveform



Numonyx 17/23

Figure 5. AC measurement load circuit

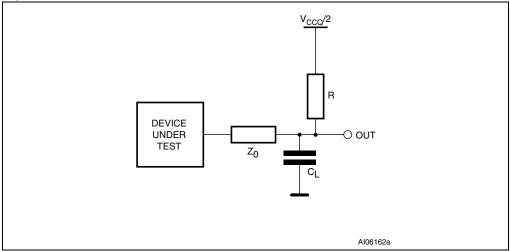


Table 5. Capacitance⁽¹⁾

| Symbol | Parameter | Test Condition | Min | Max | Unit |
|------------------|--------------------|-----------------------|-----|-----|------|
| C _{IN} | Input Capacitance | $V_{IN} = 0V$ | | 14 | pF |
| C _{OUT} | Output Capacitance | V _{OUT} = 0V | | 14 | pF |

^{1.} Sampled only, not 100% tested.

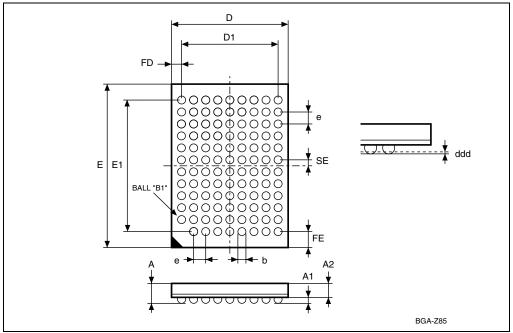
Please refer to the M58PRxxxJ and M69KB128AB datasheets for further DC and AC characteristic values and illustrations.

6 Package mechanical

In order to meet environmental requirements, Numonyx offers these devices in ECOPACK® packages. These packages have a Lead-free second-level interconnect. The category of Second-Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97.

The maximum ratings related to soldering conditions are also marked on the inner box label.

Figure 6. TFBGA107 8 \times 11mm - 9 \times 12 active ball array, 0.8mm pitch, package outline



1. Drawing is not to scale.

N numonyx 19/23

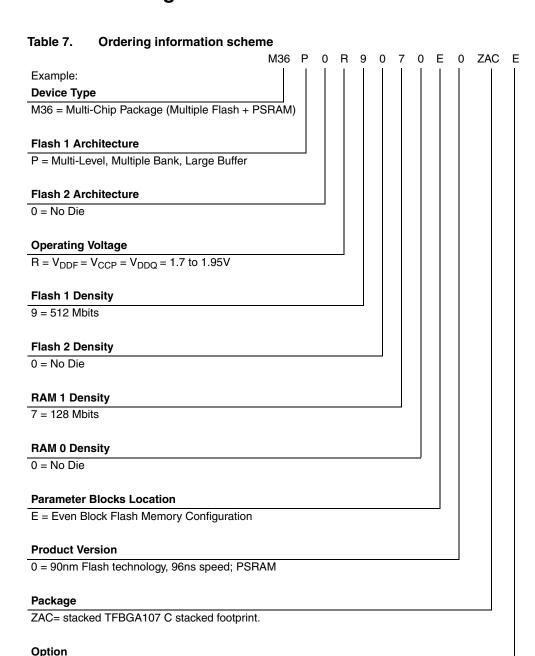
Package mechanical M36P0R9070E0

Table 6. Stacked TFBGA107 8 \times 11mm - 9 \times 12 active ball array, 0.8mm pitch, package mechanical data

| O. mah al | | millimeters | | inches | | | | |
|-----------|-------|-------------|-------|--------|-------|-------|--|--|
| Symbol | Тур | Min | Max | Тур | Min | Max | | |
| Α | | | 1.20 | | | 0.047 | | |
| A1 | | 0.20 | | | 0.008 | | | |
| A2 | 0.85 | | | 0.033 | | | | |
| b | 0.35 | 0.30 | 0.40 | 0.014 | 0.012 | 0.016 | | |
| D | 8.00 | 7.90 | 8.10 | 0.315 | 0.311 | 0.319 | | |
| D1 | 6.40 | | | 0.252 | | | | |
| ddd | | | 0.10 | | | 0.004 | | |
| Е | 11.00 | 10.90 | 11.10 | 0.433 | 0.429 | 0.437 | | |
| E1 | 8.80 | | | 0.346 | | | | |
| е | 0.80 | | | 0.031 | | | | |
| FD | 0.80 | | | 0.031 | | | | |
| FE | 1.10 | | | 0.043 | | | | |
| SE | 0.40 | | | 0.016 | | | | |

M36P0R9070E0 Part numbering

7 Part numbering



Blank = Standard Packing

E = ECOPACK® Package, Standard packing

F = ECOPACK® Package, Tape & Reel packing

Note:

Devices are shipped from the factory with the memory content bits erased to '1'. For a list of available options (Speed, Package, etc.) or for further information on any aspect of this device, please contact the Numonyx Sales Office nearest to you.

N numonyx 21/23

Revision history M36P0R9070E0

8 Revision history

Table 8. Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 28-Nov-2005 | 1 | Initial release. |
| 13-Jul-2006 | 2 | Document status promoted from Preliminary data to full Datasheet. Document updated to latest version of M58PRxxxJ datasheet, DC characteristics tables removed (for values refer to M58PRxxxJ and M69KB128AB datasheets). PSRAM part replaced by M69KB128AB. H9 ball is DU in Figure 2: TFBGA connections (top view through package). T _{STG} min and V _{PP} max modified in Table 3: Absolute maximum ratings. Table 2: Main operating modes modified. PSRAM value for Input Rise and Fall Times filled in in Table 4: Operating and AC measurement conditions. |
| 30-Nov-2007 | 3 | Applied Numonyx branding. |

Please Read Carefully:

INFORMATION IN THIS DOCUMENT IS PROVIDED IN CONNECTION WITH NUMONYX™ PRODUCTS. NO LICENSE, EXPRESS OR IMPLIED, BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT. EXCEPT AS PROVIDED IN NUMONYX'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, NUMONYX ASSUMES NO LIABILITY WHATSOEVER, AND NUMONYX DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY, RELATING TO SALE AND/OR USE OF NUMONYX PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

Numonyx products are not intended for use in medical, life saving, life sustaining, critical control or safety systems, or in nuclear facility applications.

Numonyx may make changes to specifications and product descriptions at any time, without notice.

Numonyx, B.V. may have patents or pending patent applications, trademarks, copyrights, or other intellectual property rights that relate to the presented subject matter. The furnishing of documents and other materials and information does not provide any license, express or implied, by estoppel or otherwise, to any such patents, trademarks, copyrights, or other intellectual property rights.

Designers must not rely on the absence or characteristics of any features or instructions marked "reserved" or "undefined." Numonyx reserves these for future definition and shall have no responsibility whatsoever for conflicts or incompatibilities arising from future changes to them.

Contact your local Numonyx sales office or your distributor to obtain the latest specifications and before placing your product order.

Copies of documents which have an order number and are referenced in this document, or other Numonyx literature may be obtained by visiting Numonyx's website at http://www.numonyx.com.

Numonyx StrataFlash is a trademark or registered trademark of Numonyx or its subsidiaries in the United States and other countries.

*Other names and brands may be claimed as the property of others.

Copyright © 11/5/7, Numonyx, B.V., All Rights Reserved.

